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9	BRS	L9	69	lanthanum adj aluminum adj oxide	USPAT; EPO; JPO; DERWEN T; IBM_TD B	2004/03/09 13:45
10	BRS	L10	20	9 and (evaporate evaporation evaporating)	USPAT; EPO; JPO; DERWEN T; IBM_TD B	2004/03/09 13:45
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